# 2SD1350, 2SD1350A

### Silicon NPN triple diffusion planar type

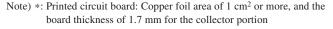
For high breakdown voltage switching

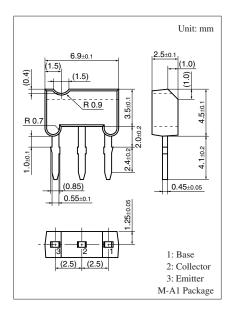
#### ■ Features

- $\bullet$  High collector-base voltage (Emitter open)  $V_{CBO}$
- Large collector power dissipation P<sub>C</sub>
- $\bullet$  Low collector-emitter saturation voltage  $V_{\text{CE}(\text{sat})}$
- M type package, allowing easy automatic and manual insertion as well as stand-alone fixing to the printed circuit board.

#### ■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit		
Collector-base voltage	2SD1350	V <sub>CBO</sub>	400	V	
(Emitter open)	2SD1350A		600		
Collector-emitter voltage	2SD1350	V <sub>CEO</sub>	400	V	
(Base open)	2SD1350A		500		
Emitter-base voltage (Col	$V_{EBO}$	5	V		
Collector current	$I_{C}$	500	mA		
Peak collector current	$I_{CP}$	1	A		
Collector power dissipation	P <sub>C</sub>	1	W		
Junction temperature	$T_{j}$	150	°C		
Storage temperature	$T_{stg}$	-55 to +150	°C		

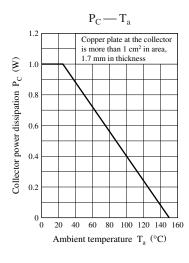


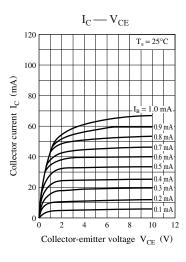


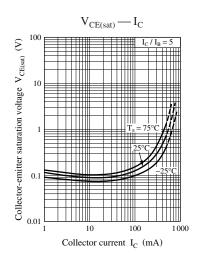
### ■ Electrical Characteristics $T_a = 25$ °C $\pm 3$ °C

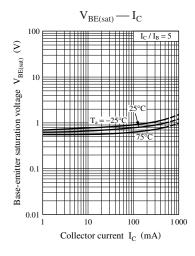
Parameter		Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage 2SD1350		V <sub>CBO</sub>	$I_C = 100 \mu\text{A},  I_E = 0$	400			V
(Emitter open)	2SD1350A			600			
Collector-emitter voltage	2SD1350	V <sub>CEO</sub>	$I_C = 500 \ \mu A, I_B = 0$	400			V
(Base open)	2SD1350A			500			
Emitter-base voltage (Collector open)		V <sub>EBO</sub>	$I_E = 100 \mu\text{A},  I_C = 0$	5			V
Forward current transfer ratio		h <sub>FE</sub>	$V_{CE} = 5 \text{ V}, I_{C} = 30 \text{ mA}$	30			_
Collector-emitter saturation voltage		V <sub>CE(sat)</sub>	$I_C = 250 \text{ mA}, I_B = 50 \text{ mA}$			1.5	V
Base-emitter saturation voltage		V <sub>BE(sat)</sub>	$I_C = 250 \text{ mA}, I_B = 50 \text{ mA}$			1.5	V
Transition frequency		$f_T$	$V_{CB} = 30 \text{ V}, I_E = -20 \text{ mA}, f = 200 \text{ MHz}$		55		MHz
Collector output capacitance		C <sub>ob</sub>	$V_{CB} = 30 \text{ V}, I_E = 0, f = 1 \text{ MHz}$			7	pF
(Common base, input open circuited)							
Turn-on time		t <sub>on</sub>	$V_{CC} = 200 \text{ V}, I_{C} = 100 \text{ mA}$		0.4		μs
			$I_{B1} = 10 \text{ mA}, I_{B2} = -10 \text{ mA}$				
Fall time		$t_{\rm f}$	$V_{CC} = 200 \text{ V}, I_{C} = 100 \text{ mA}$		0.7		μs
			$I_{B1} = 10 \text{ mA}, I_{B2} = -10 \text{ mA}$				
Storage time		t <sub>stg</sub>	$V_{CC} = 200 \text{ V}, I_{C} = 100 \text{ mA}$		3.6		μs
			$I_{B1} = 10 \text{ mA}, I_{B2} = -10 \text{ mA}$				

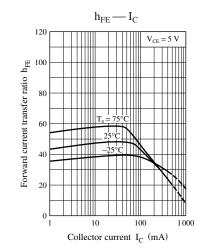
Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

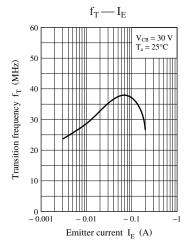


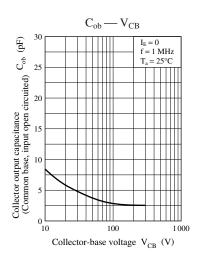












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